

Notice of References Cited		Application/Control No. 10/576,285	Applicant(s)/Patent Under Reexamination FRAISSE ET AL.	
		Examiner CATHERINE THIAW	Art Unit 2458	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0044818	11-2001	Liang, Yufeng	709/201
*	B	US-2003/0126267	07-2003	Gutta et al.	709/229
*	C	US-5,884,033	03-1999	Duvall et al.	709/206
*	D	US-2004/0255321	12-2004	Matz, William R.	725/014
*	E	US-2004/0006767	01-2004	Robson et al.	725/28
*	F	US-2003/0182420	09-2003	Jones et al.	709/224
*	G	US-2006/0256788	11-2006	Donahue, David B.	370/389
*	H	US-2005/0091328	04-2005	Saeidi, Babak	709/206
*	I	US-2005/0060581	03-2005	Chebolu et al.	713/201
*	J	US-2005/0028191	02-2005	Sullivan et al.	725/028
*	K	US-2004/0040034	02-2004	Sullivan et al.	725/25
*	L	US-2002/0065730	05-2002	Nii, Naoaki	705/26
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	W					
	X					

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